

Electrical Characteristics @ Tj = 25°C (Unless Otherwise Specified)

	Parameter	Min.	Тур.	Max.	Units	Test Conditions
BV _{DSS}	Drain-to-Source Breakdown Voltage	-100			V	$V_{GS} = 0V, I_{D} = -1.0mA$
$\Delta BV_{DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		-0.1		V/°C	Reference to 25°C, I _D = -1.0mA
R _{DS(on)}	Static Drain-to-Source On-State Resistance			0.20	Ω	V _{GS} = -10V, I _D = -10A ④
$V_{GS(th)}$	Gate Threshold Voltage	-2.0		-4.0	V	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$
Gfs	Forward Transconductance	6.2			S	V _{DS} = -15V, I _D = -10A ④
I _{DSS}	Zoro Cato Voltago Drain Current			-25	μA	V_{DS} = -80V, V_{GS} = 0V
	Zero Gate Voltage Drain Current			-250		$V_{DS} = -80V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I _{GSS}	Gate-to-Source Leakage Forward			-100	nA	V _{GS} = -20V
	Gate-to-Source Leakage Reverse			100	ш	V _{GS} = 20V
Q_G	Total Gate Charge			60		I _D = -15.8A
Q_{GS}	Gate-to-Source Charge			13	nC	V _{DS} = -50V
Q_{GD}	Gate-to-Drain ('Miller') Charge			35.2		V _{GS} = -10V
t _{d(on)}	Turn-On Delay Time			35		$V_{DD} = -50V$
tr	Rise Time			85	no	I _D = -15.8A
$t_{d(off)}$	Turn-Off Delay Time			85	ns	$R_G = 7.5\Omega$
t _f	Fall Time			65		V _{GS} = -10V
Ls +L _D	Total Inductance		6.8		nH	Measured from Drain lead (6mm / 0.25 in from package) to Source lead (6mm/ 0.25 in from package) with Source wire internally bonded from Source pin to Drain pad
C _{iss}	Input Capacitance		1400			V _{GS} = 0V
Coss	Output Capacitance		600		pF	V _{DS} = -25V
C _{rss}	Reverse Transfer Capacitance		200			f = 1.0MHz

Source-Drain Diode Ratings and Characteristics

	Parameter	Min.	Тур.	Max.	Units	Test Conditions
Is	Continuous Source Current (Body Diode)			-15.8	^	
I _{SM}	Pulsed Source Current (Body Diode) ①			-60	Α	
V_{SD}	Diode Forward Voltage			-5.0	V	$T_J = 25^{\circ}C, I_S = -15.8A, V_{GS} = 0V$
t _{rr}	Reverse Recovery Time			280	ns	$T_J = 25^{\circ}C, I_F = -15.8A, V_{DD} \le -50V$
Q _{rr}	Reverse Recovery Charge			3.6	μC	di/dt = -100A/µs ④
t _{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S + L_D$)				

Thermal Resistance

	Parameter	Min.	Тур.	Max.	Units	Test Conditions
$R_{\theta JC}$	Junction-to-Case			1.25		
$R_{\theta CS}$	Case-to-sink		0.21		°C/W	
$R_{\theta JA}$	Junction-to-Ambient			80		Typical socket mount

Footnotes:

- ① Repetitive Rating; Pulse width limited by maximum junction temperature.
- $^{\circ}$ V_{DD} = -50V, starting T_J = 25°C, L =5.1mH, Peak I_L = -15.8A, V_{GS} = -10V
- $\label{eq:loss_def} \text{ } \text{ } \text{ } I_{SD} \leq \text{-15.8A, di/dt} \leq \text{-200A/}\mu\text{s, } V_{DD} \leq \text{-100V, } T_{J} \leq \text{150}^{\circ}\text{C}$

2 2016-09-21

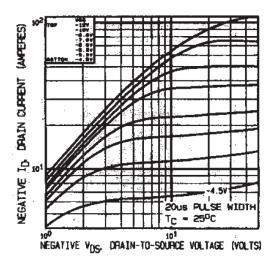


Fig 1. Typical Output Characteristics

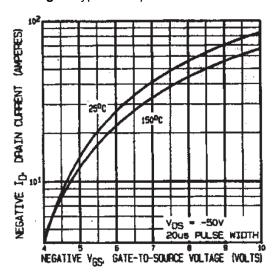


Fig 3. Typical Transfer Characteristics

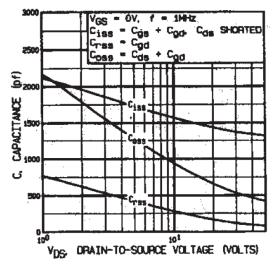


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

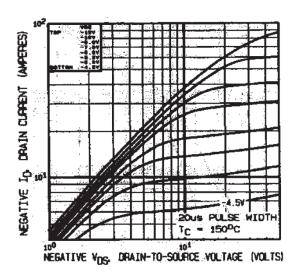


Fig 2. Typical Output Characteristics

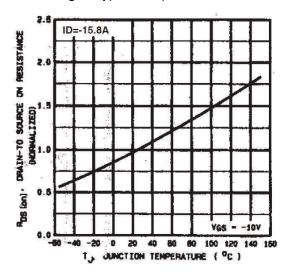


Fig 4. Normalized On-Resistance Vs. Temperature

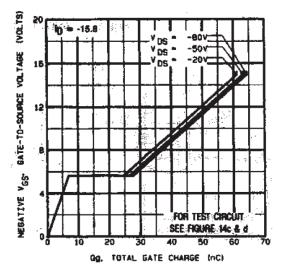


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

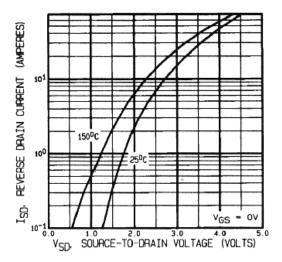


Fig 7. Typical Source-Drain Diode Forward Voltage

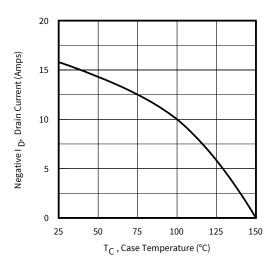


Fig 9. Maximum Drain Current Vs. Case Temperature

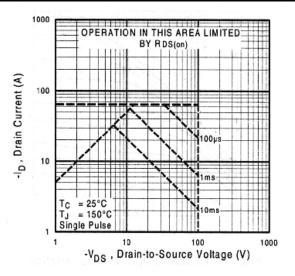


Fig 8. Maximum Safe Operating Area

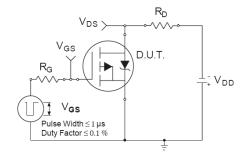


Fig 10a. Switching Time Test Circuit

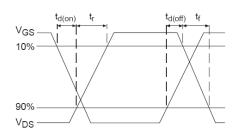


Fig 10b. Switching Time Waveforms

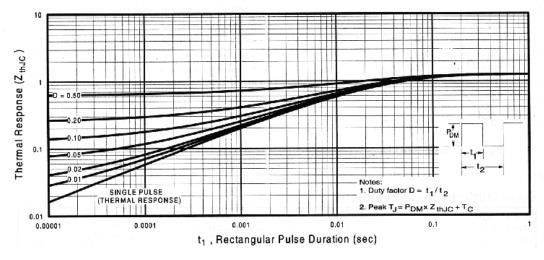


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case



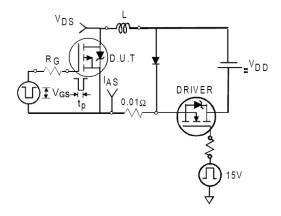


Fig 12a. Unclamped Inductive Test Circuit

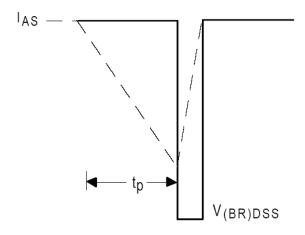


Fig 12b. Unclamped Inductive Waveforms

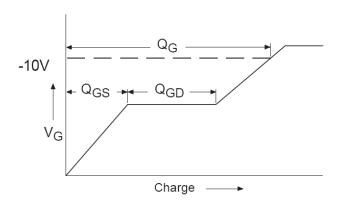


Fig 13a. Basic Gate Charge Waveform

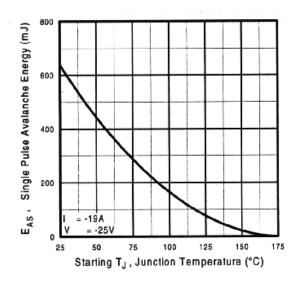


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

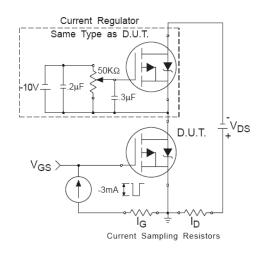
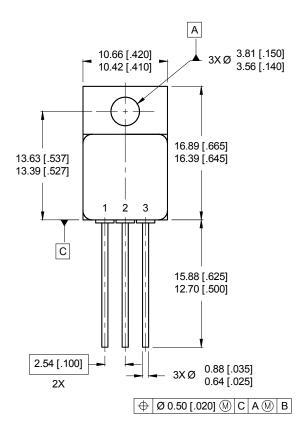
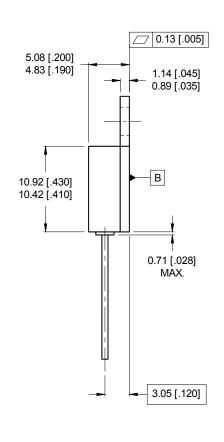


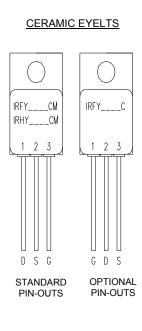
Fig 13b. Gate Charge Test Circuit



Case Outline and Dimensions — TO-257AA







NOTES:

- 1. DIMENSIONING & TOLERANCING PER ANSI Y14.5M-1994.
- 2. CONTROLLING DIMENSION: INCH.
- 3. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- 4. OUTLINE CONFORMS TO JEDEC OUTLINE TO-257AA.

LEAD ASSIGNMENT

- 1 = DRAIN
- 2 = SOURCE
- 3 = GATE



An Infineon Technologies Company

IR HiRel Headquarters: 101 N. Sepulveda Blvd., El Segundo, California 90245, USA Tel: (310) 252-7105
IR HiRel Leominster: 205 Crawford St., Leominster, Massachusetts 01453, USA Tel: (978) 534-5776
IR HiRel San Jose: 2520 Junction Avenue, San Jose, California 95134, USA Tel: (408) 434-5000
Data and specifications subject to change without notice.



IMPORTANT NOTICE

The information given in this document shall be in no event regarded as guarantee of conditions or characteristic. The data contained herein is a characterization of the component based on internal standards and is intended to demonstrate and provide guidance for typical part performance. It will require further evaluation, qualification and analysis to determine suitability in the application environment to confirm compliance to your system requirements.

With respect to any example hints or any typical values stated herein and/or any information regarding the application of the product, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind including without limitation warranties on non- infringement of intellectual property rights and any third party.

In addition, any information given in this document is subject to customer's compliance with its obligations stated in this document and any applicable legal requirements, norms and standards concerning customer's product and any use of the product of Infineon Technologies in customer's applications.

The data contained in this document is exclusively intended for technically trained staff. It is the responsibility of any customer's technical departments to evaluate the suitability of the product for the intended applications and the completeness of the product information given in this document with respect to applications.

For further information on the product, technology, delivery terms and conditions and prices, please contact your local sales representative or go to (www.infineon.com/hirel).

WARNING

Due to technical requirements products may contain dangerous substances. For information on the types in question, please contact your nearest Infineon Technologies office.

7 2016-09-21